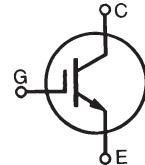


HiPerFAST™ IGBT IXGR 120N60B

ISOPLUS247™

(Electrically Isolated Back Surface)

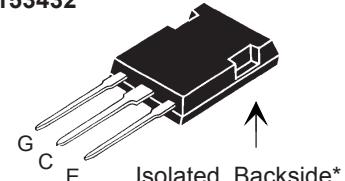
V_{CES} = 600 V
 I_{C25} = 156 A
 $V_{CE(sat)}$ = 2.1 V



| Symbol | Test Conditions | Maximum Ratings | | |
|---|---|-----------------------------------|--|----|
| V_{CES} | T_J = 25°C to 150°C | 600 | | V |
| V_{CGR} | T_J = 25°C to 150°C; R_{GE} = 1 MΩ | 600 | | V |
| V_{GES} | Continuous | ±20 | | V |
| V_{GEM} | Transient | ±30 | | V |
| I_{C25} | T_c = 25°C | 156 | | A |
| I_{C110} | T_c = 110°C | 102 | | A |
| $I_{L(RMS)}$ | External lead limit | 76 | | A |
| I_{CM} | T_c = 25°C, 1 ms | 300 | | A |
| SSOA (RBSSOA) | $V_{GE} = 15$ V, $T_{VJ} = 125$ °C, $R_G = 2.4$ Ω Clamped inductive load | $I_{CM} = 200$ @ 0.8 V_{CES} | | A |
| P_c | T_c = 25°C | 520 | | W |
| T_J | | -55 ... +150 | | °C |
| T_{JM} | | 150 | | °C |
| T_{stg} | | -55 ... +150 | | °C |
| Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s | | 300 | | °C |
| V_{ISOL} | 50/60 Hz, RMS, t = 1 minute leads-to-tab | 2500 | | V |
| Weight | | 5 | | g |

| Symbol | Test Conditions | Characteristic Values | | |
|---------------|--|---|------|----------------|
| | | (T_J = 25°C, unless otherwise specified) | min. | typ. |
| BV_{CES} | I_c = 1 mA, V_{GE} = 0 V | 600 | | V |
| $V_{GE(th)}$ | I_c = 1 mA, $V_{CE} = V_{GE}$ | 2.5 | | 5.5 V |
| I_{CES} | $V_{CE} = 0.8 \cdot V_{CES}$ $V_{GE} = 0$ V | $T_J = 25$ °C $T_J = 150$ °C | | 200 μA 2 mA |
| I_{GES} | $V_{CE} = 0$ V, $V_{GE} = \pm 20$ V | | | ±400 nA |
| $V_{CE(sat)}$ | I_c = 100A, V_{GE} = 15 V (see note 1) | | | 2.1 V |

ISOPLUS 247



G = Gate, C = Collector
E = Emitter

* Patent pending

Features

- DCB Isolated mounting tab
- Meets TO-247AD package Outline
- High current handling capability
- Latest generation HDMOS™ process
- MOS Gate turn-on
 - drive simplicity

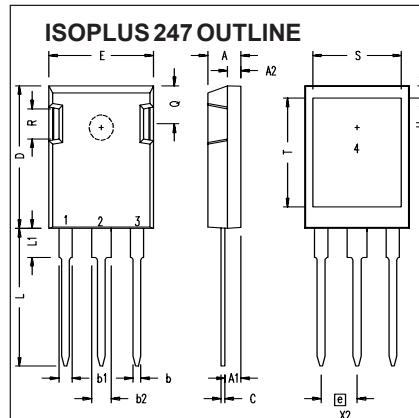
Applications

- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies
- AC motor speed control
- DC servo and robot drives
- DC choppers

Advantages

- Easy assembly
- High power density
- Very fast switching speeds for high frequency applications

| Symbol | Test Conditions | Characteristic Values | | | |
|--------------|--|--|------|------|------|
| | | ($T_J = 25^\circ\text{C}$, unless otherwise specified) | min. | typ. | max. |
| g_{fs} | $I_C = 60\text{A}; V_{CE} = 10\text{V},$ Pulse test, $t \leq 300\text{\mu s}$, duty cycle $\leq 2\%$ | 50 | 75 | S | |
| C_{ies} | $V_{CE} = 25\text{V}, V_{GE} = 0\text{V}, f = 1\text{MHz}$ | 11000 | | pF | |
| C_{oes} | | 680 | | pF | |
| C_{res} | | 190 | | pF | |
| Q_g | $I_C = 100\text{A}, V_{GE} = 15\text{V}, V_{CE} = 0.5\text{V}_{CES}$ | 350 | | nC | |
| Q_{ge} | | 72 | | nC | |
| Q_{gc} | | 131 | | nC | |
| $t_{d(on)}$ | Inductive load, $T_J = 25^\circ\text{C}$ $I_C = 100\text{A}, V_{GE} = 15\text{V}$ $V_{CE} = 0.8 \cdot V_{CES}, R_G = R_{off} = 2.4\Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_J or increased R_G | 60 | | ns | |
| t_{ri} | | 45 | | ns | |
| E_{on} | | 2.4 | | mJ | |
| $t_{d(off)}$ | | 200 | 360 | ns | |
| t_{fi} | | 160 | 280 | ns | |
| E_{off} | | 5.5 | 9.6 | mJ | |
| $t_{d(on)}$ | Inductive load, $T_J = 125^\circ\text{C}$ $I_C = 100\text{A}, V_{GE} = 15\text{V}$ $V_{CE} = 0.8 \cdot V_{CES}, R_G = R_{off} = 2.4\Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_J or increased R_G | 60 | | ns | |
| t_{ri} | | 60 | | ns | |
| E_{on} | | 4.8 | | mJ | |
| $t_{d(off)}$ | | 290 | | ns | |
| t_{fi} | | 250 | | ns | |
| E_{off} | | 8.7 | | mJ | |
| R_{thJC} | | | 0.3 | K/W | |
| R_{thCK} | | 0.15 | | K/W | |



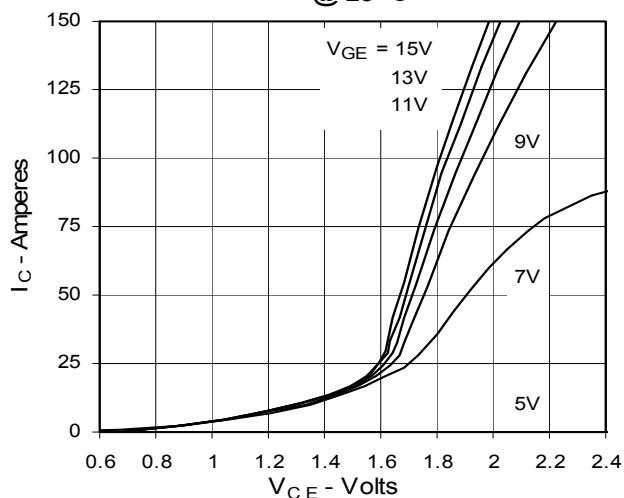
1 Gate, 2 Drain (Collector)
3 Source (Emitter)
4 no connection

| Dim. | Millimeter | | Inches | |
|----------------|------------|-------|--------|------|
| | Min. | Max. | Min. | Max. |
| A | 4.83 | 5.21 | .190 | .205 |
| A ₁ | 2.29 | 2.54 | .090 | .100 |
| A ₂ | 1.91 | 2.16 | .075 | .085 |
| b | 1.14 | 1.40 | .045 | .055 |
| b ₁ | 1.91 | 2.13 | .075 | .084 |
| b ₂ | 2.92 | 3.12 | .115 | .123 |
| C | 0.61 | 0.80 | .024 | .031 |
| D | 20.80 | 21.34 | .819 | .840 |
| E | 15.75 | 16.13 | .620 | .635 |
| e | 5.45 | BSC | .215 | BSC |
| L | 19.81 | 20.32 | .780 | .800 |
| L1 | 3.81 | 4.32 | .150 | .170 |
| Q | 5.59 | 6.20 | .220 | .244 |
| R | 4.32 | 4.83 | .170 | .190 |

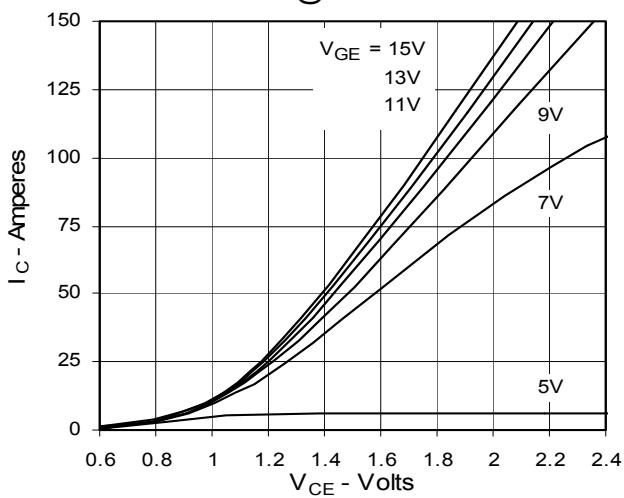
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463

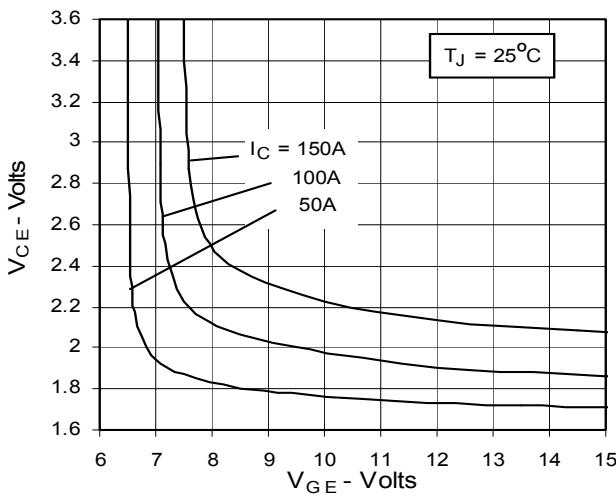
**Fig. 1. Output Characteristics
@ 25 °C**



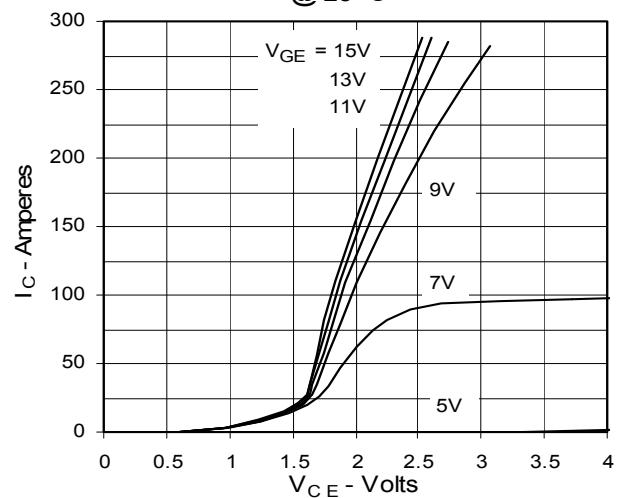
**Fig. 3. Output Characteristics
@ 125 °C**



**Fig. 5. Collector-to-Emitter Voltage
vs. Gate-to-Emitter voltage**



**Fig. 2. Extended Output Characteristics
@ 25 °C**



**Fig. 4. Dependence of $V_{CE(sat)}$ on
Temperature**

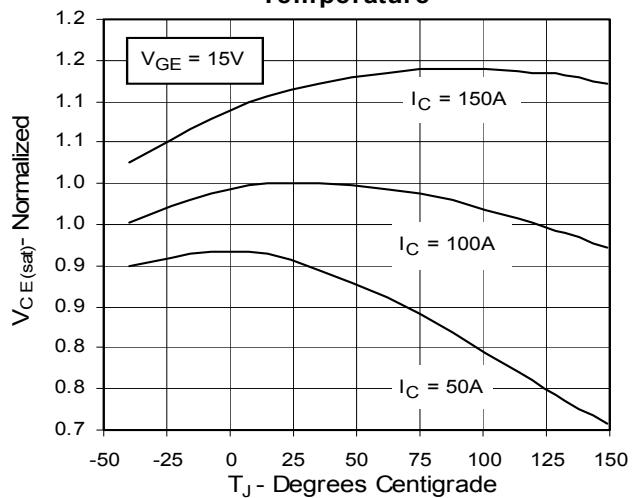


Fig. 6. Input Admittance

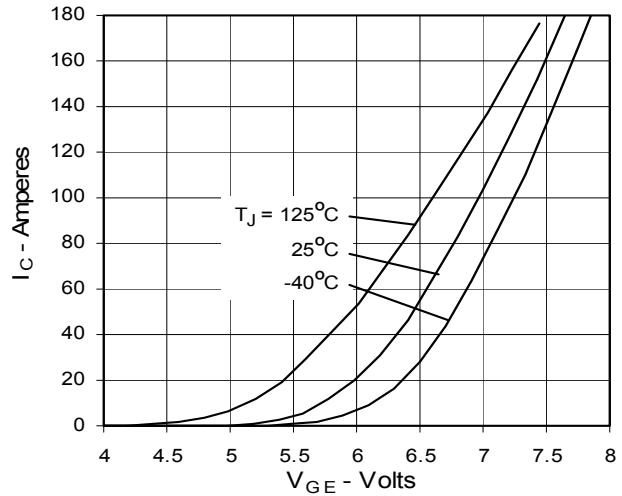
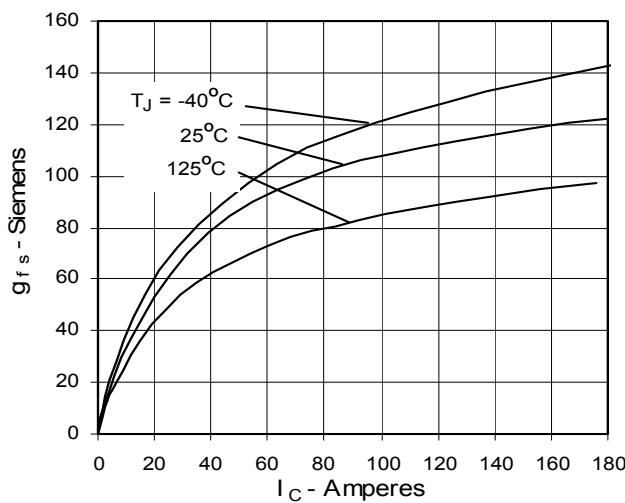
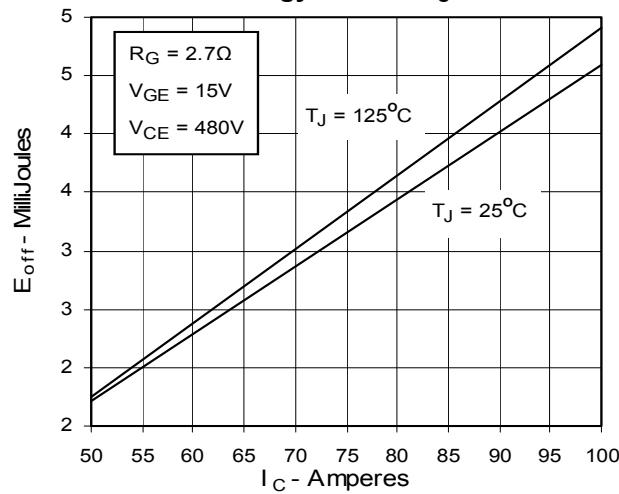
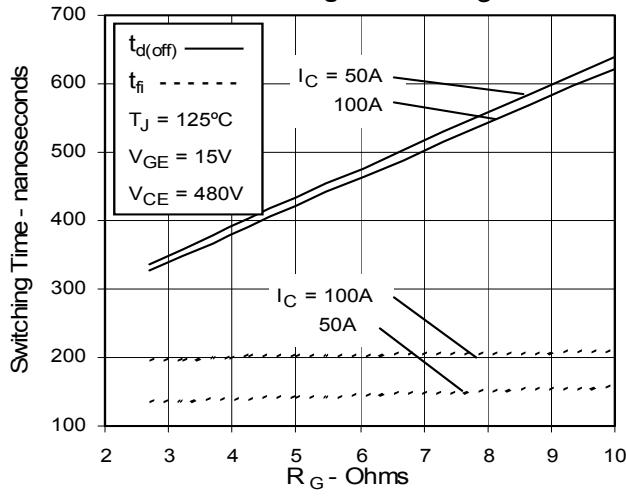
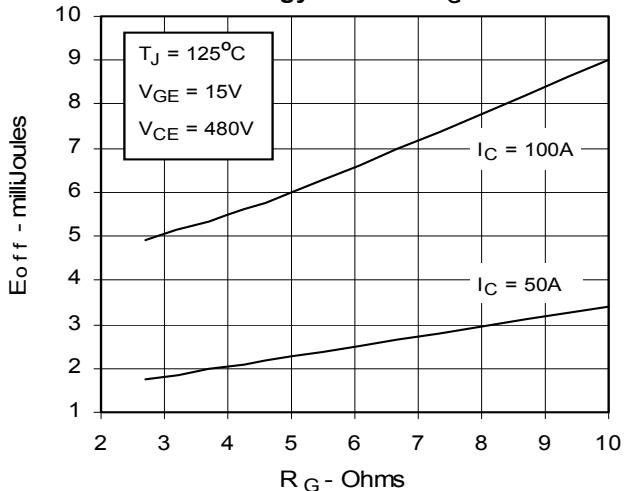
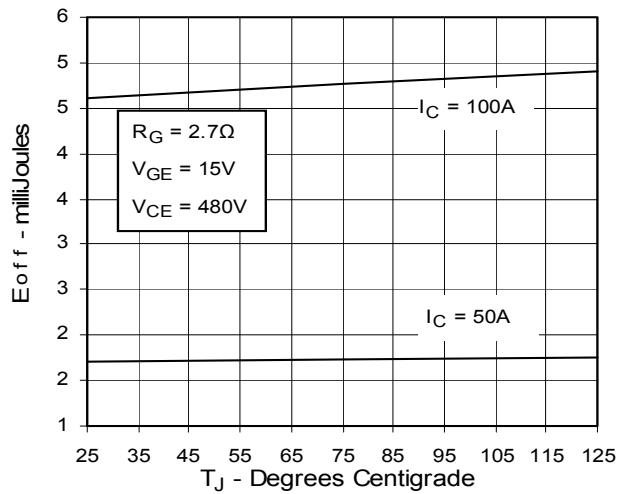
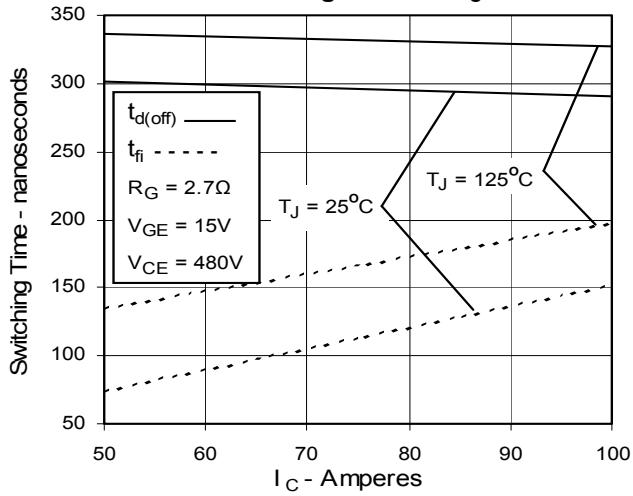


Fig. 7. Transconductance

Fig. 9. Dependence of Turn-Off Energy Loss on I_C

Fig. 11. Dependence of Turn-off Switching Time on R_G

Fig. 8. Dependence of Turn-off Energy Loss on R_G

Fig. 10. Dependence of Turn-off Energy Loss on Temperature

Fig. 12. Dependence of Turn-off Switching Time on I_C


**Fig. 13. Dependence of Turn-off
Switching Time on Temperature**

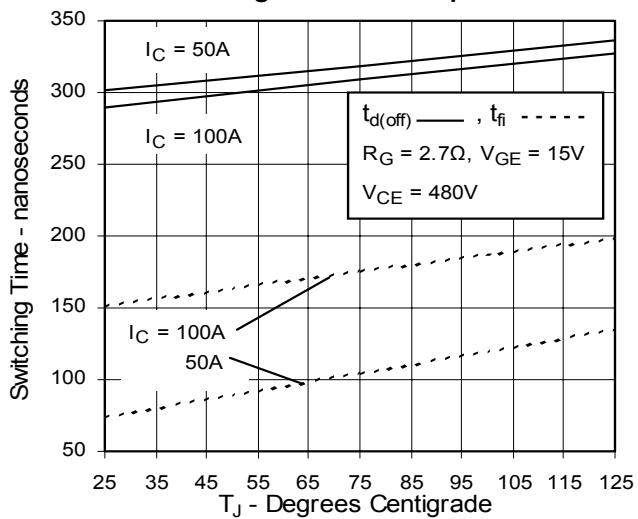


Fig. 14. Gate Charge

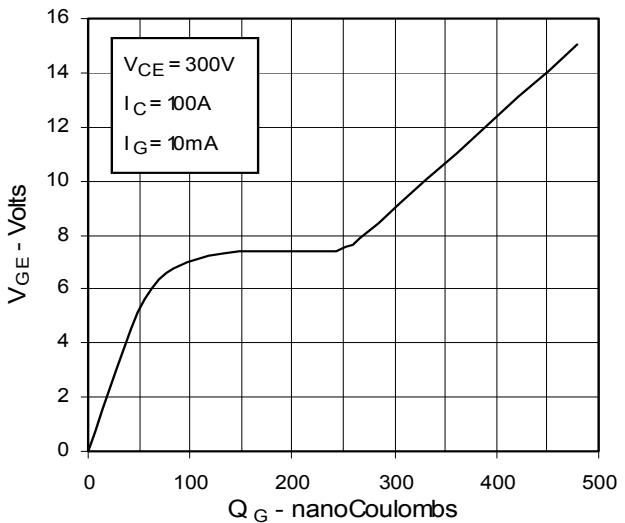
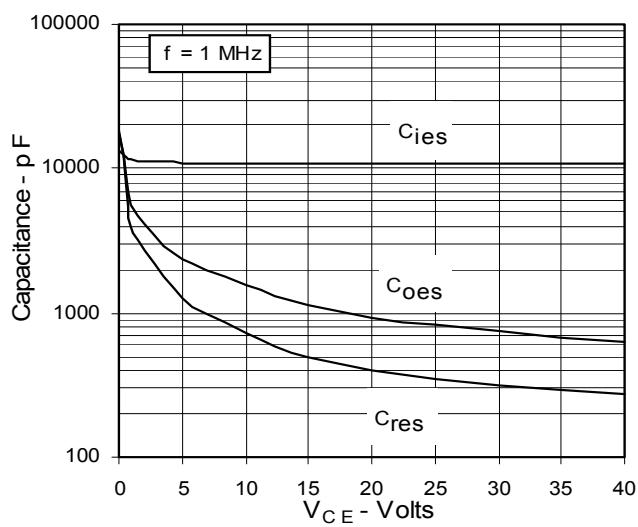


Fig. 15. Capacitance



**Fig. 16. Reverse-Bias Safe
Operating Area**

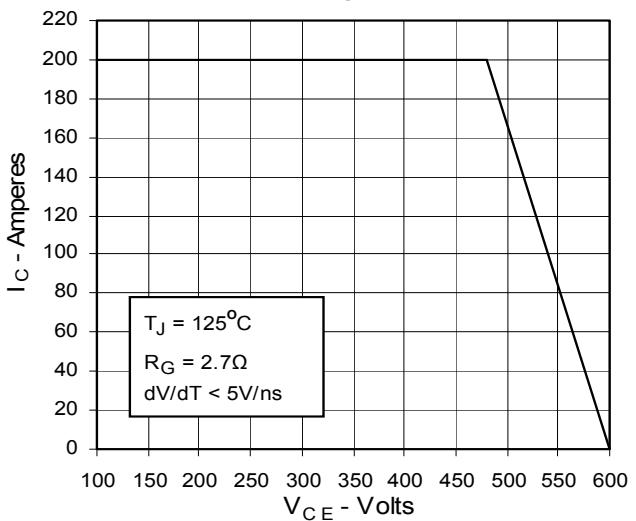


Fig. 17. Maximum Transient Thermal Resistance

